

**Search Notes**

Application/Control No.

10/644,966

Examiner

Lois Zheng

Applicant(s)/Patent under  
Reexamination

NAKAZAWA ET AL.

Art Unit

1742

**SEARCHED**

Class	Subclass	Date	Examiner
204	232	10/27/2005	LLZ
204	237-238	10/27/2005	LLZ
204	240	10/27/2005	LLZ
204	242	10/27/2005	LLZ
204	275.1	10/27/2005	LLZ
205	637	10/27/2005	LLZ
205	633	10/27/2005	LLZ
205	334	10/27/2005	LLZ
204	252	10/27/2005	LLZ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventorship Search	10/27/2005	LLZ
See EAST Search History	10/27/2005	LLZ